Notice of References Cited Application/Control No. 10/594,774 Examiner MARY ANNE KAY Applicant(s)/Patent Under Reexamination SHINDO ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0166123	11-2002	Schrader et al.	725/58
*	В	US-7,272,843	09-2007	Nejime et al.	725/32
*	С	US-2006/0041915	02-2006	Dimitrova et al.	725/081
*	D	US-2003/0154217	08-2003	Kinno et al.	707/104.1
*	Е	US-2002/0144007	10-2002	Shteyn, Yevgeniy Eugene	709/313
*	F	US-6,678,332	01-2004	Gardere et al.	375/240.26
*	G	US-6,360,218	03-2002	Zander et al.	1/1
*	Н	US-2004/0249861	12-2004	Hoshino et al.	707/104.1
*	ı	US-7,134,074	11-2006	Munetsugu et al.	715/204
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.